

Issue Classification

Application/Control No.

10811403

Applicant(s)/Patent Under Reexamination

CHEN ET AL.

Examiner

Tran, Mai T

Art Unit

2129

ORIGINAL

CLASS

706

SUBCLASS

15

CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

706

19

702

6

INTERNATIONAL CLASSIFICATION

CLAIMED

G O B E

1 / 00 (2006.01.01)

NON-CLAIMED

Tran, Mai T

06/12/2007

(Assistant Examiner)

(Date)

**DAVID VINCENT
SUPERVISORY PATENT EXAMINER**

Total Claims Allowed:

18

(Legal Instruments
Examiner)

(Date)

David Vincent

(Primary Examiner)

06/12/2007

(Date)

O.G. Print Claim(s)

1

O.G. Print Figure

1